MITSUBISHI ELECTRIC

<IGBT Modules>

CM200DX-34SA

HIGH POWER SWITCHING USE
INSULATED TYPE

dual switch (half-bridge)

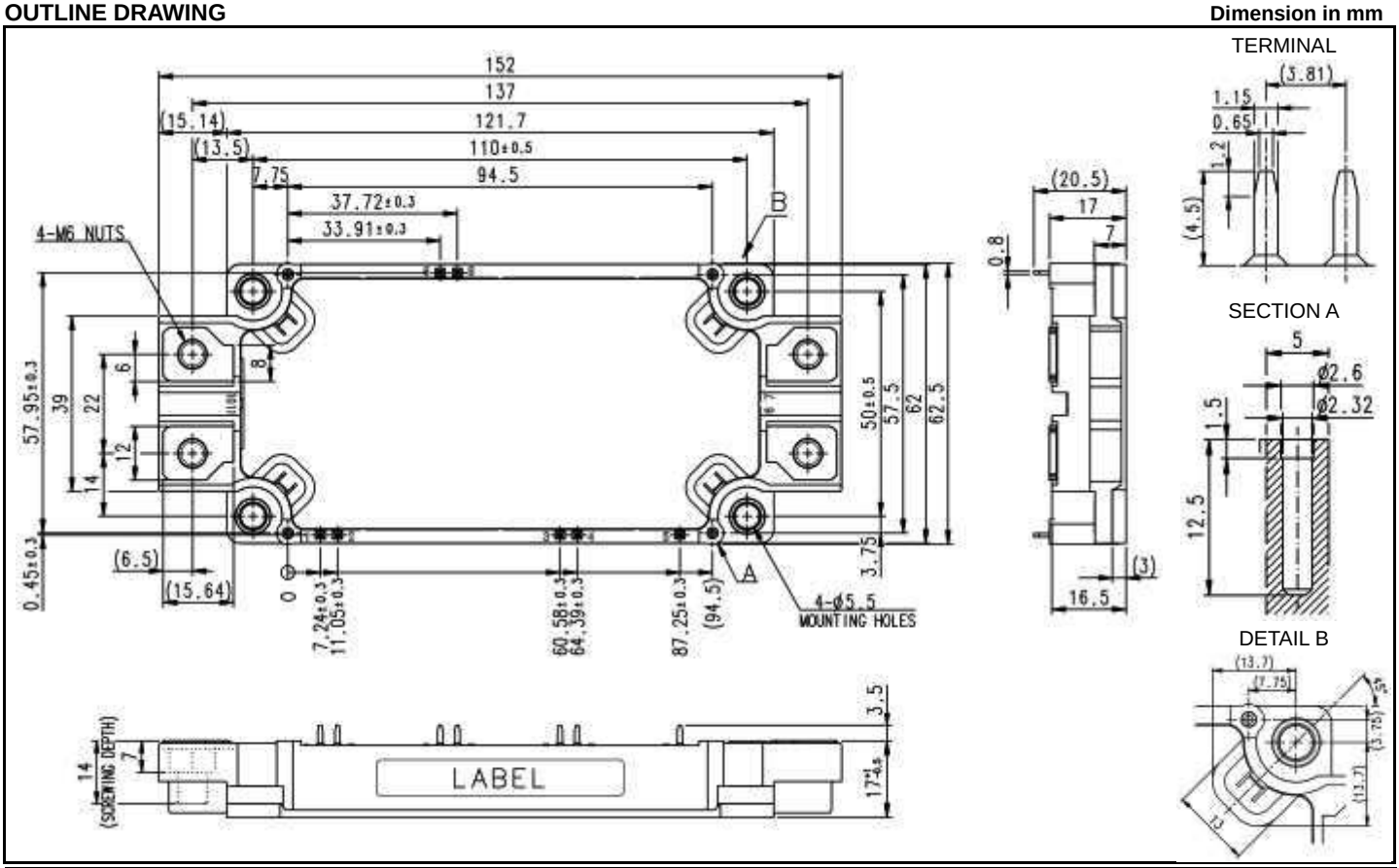
Collector current I_C ..... **200** A
Collector-emitter voltage V_{CES} ..... **1700** V
Maximum junction temperature T_{vjmax} ..... **175** °C

- ●Flat base type
- ●Copper base plate (non-plating)
- ●RoHS Directive compliant
- ●Tin-plating pin terminals
- ●UL Recognized under UL1557, File No. E323585

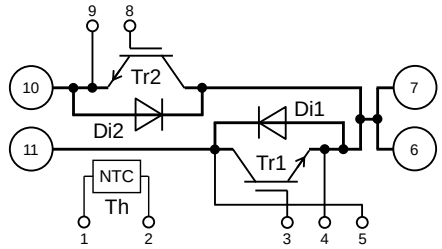
APPLICATION

AC Motor Control, Motion/Servo Control, Power supply, etc.

OUTLINE DRAWING **Dimension in mm**



INTERNAL CONNECTION



Terminal code

1. TH1	6. C2E1
2. TH2	7. C2E1
3. G1	8. G2
4. Es1	9. Es2
5. Cs1	10. E2
	11. C1

Tolerance otherwise specified

Division of Dimension		Tolerance
0.5	to 3	±0.2
over 3	to 6	±0.3
over 6	to 30	±0.5
over 30	to 120	±0.8
over 120	to 400	±1.2

MAXIMUM RATINGS (T_{vj}=25 °C, unless otherwise specified)

INVERTER PART IGBT/FWD

Symbol	Item	Conditions	Rating	Unit
V_{CES}	Collector-emitter voltage	G-E short-circuited	1700	V
V_{GES}	Gate-emitter voltage	C-E short-circuited	± 20	V
I_C	Collector current	DC, T_C=125 °C (Note2, 4)	200	A
I_{CRM}		Pulse, Repetitive (Note3)	400	
P_{tot}	Total power dissipation	T_C=25 °C (Note2, 4)	2000	W
I_E (Note1)	Emitter current	DC (Note2)	200	A
I_{ERM} (Note1)		Pulse, Repetitive (Note3)	400	

MODULE

Symbol	Item	Conditions	Rating	Unit
V_{isol}	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	4000	V
T_{vjmax}	Maximum junction temperature	Instantaneous event (overload)	175	°C
T_{Cmax}	Maximum case temperature	(Note4)	125	
T_{vjop}	Operating junction temperature	Continuous operation (under switching)	-40 ~ +150	°C
T_{stg}	Storage temperature	-	-40 ~ +125	

ELECTRICAL CHARACTERISTICS (T_{vj}=25 °C, unless otherwise specified)

INVERTER PART IGBT/FWD

Symbol	Item	Conditions		Limits			Unit
				Min.	Typ.	Max.	
I_{CES}	Collector-emitter cut-off current	V_{CE}=V_{CES}, G-E short-circuited		-	-	1.0	mA
I_{GES}	Gate-emitter leakage current	V_{GE}=V_{GES}, C-E short-circuited		-	-	0.5	μA
$V_{GE(th)}$	Gate-emitter threshold voltage	I_C=20 mA, V_{CE}=10 V		5.4	6.0	6.6	V
V_{CEsat} (Terminal)	Collector-emitter saturation voltage	I_C=200 A, V_{GE}=15 V, Refer to the figure of test circuit (Note5)	T_{vj}=25 °C	-	2.00	2.50	V
			T_{vj}=125 °C	-	2.20	-	
			T_{vj}=150 °C	-	2.25	-	
V_{CEsat} (Chip)		I_C=200 A, V_{GE}=15 V, (Note5)	T_{vj}=25 °C	-	1.90	2.40	V
			T_{vj}=125 °C	-	2.10	-	
			T_{vj}=150 °C	-	2.15	-	
C_{ies}	Input capacitance	V_{CE}=10 V, G-E short-circuited		-	-	53	nF
C_{oes}	Output capacitance			-	-	4.3	
C_{res}	Reverse transfer capacitance			-	-	0.97	
Q_G	Gate charge	V_{CC}=1000 V, I_C=200 A, V_{GE}=15 V		-	1100	-	nC
$t_{d(on)}$	Turn-on delay time	V_{CC}=1000 V, I_C=200 A, V_{GE}=±15 V, R_G=0 Ω, Inductive load		-	-	400	ns
t_r	Rise time			-	-	100	
$t_{d(off)}$	Turn-off delay time			-	-	700	
t_f	Fall time			-	-	600	
V_{EC} (Note1) (Terminal)	Emitter-collector voltage	I_E=200 A, G-E short-circuited, Refer to the figure of test circuit (Note5)	T_{vj}=25 °C	-	4.1	5.3	V
			T_{vj}=125 °C	-	2.9	-	
			T_{vj}=150 °C	-	2.7	-	
V_{EC} (Note1) (Chip)		I_E=200 A, G-E short-circuited, (Note5)	T_{vj}=25 °C	-	4.0	5.2	V
			T_{vj}=125 °C	-	2.8	-	
			T_{vj}=150 °C	-	2.6	-	
t_{rr} (Note1)	Reverse recovery time	V_{CC}=1000 V, I_E=200 A, V_{GE}=±15 V, R_G=0 Ω, Inductive load		-	-	300	ns
Q_{rr} (Note1)	Reverse recovery charge			-	8.0	-	μC
E_{on}	Turn-on switching energy per pulse	V_{CC}=1000 V, I_C=I_E=200 A, V_{GE}=±15 V, R_G=0 Ω, T_{vj}=150 °C, Inductive load		-	28	-	mJ
E_{off}	Turn-off switching energy per pulse			-	52	-	
E_{rr} (Note1)	Reverse recovery energy per pulse			-	42	-	mJ
$R_{CC'+EE'}$	Internal lead resistance	Main terminals-chip, per switch, T_C=25 °C (Note4)		-	-	1.2	mΩ
r_g	Internal gate resistance	Per switch		-	2.5	-	Ω

ELECTRICAL CHARACTERISTICS (cont.; T_{vj}=25 °C, unless otherwise specified)

NTC THERMISTOR PART

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
R_{25}	Zero-power resistance	T_C=25 °C (Note4)	4.85	5.00	5.15	kΩ
ΔR/R	Deviation of resistance	R_{100}=493 Ω, T_C=100 °C (Note4)	-7.3	-	+7.8	%
$B_{(25/50)}$	B-constant	Approximate by equation (Note6)	-	3375	-	K
P_{25}	Power dissipation	T_C=25 °C (Note4)	-	-	10	mW

THERMAL RESISTANCE CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
$R_{th(j-c)Q}$	Thermal resistance	Junction to case, per Inverter IGBT (Note4)	-	-	75	K/kW
$R_{th(j-c)D}$		Junction to case, per Inverter FWD (Note4)	-	-	120	
$R_{th(c-s)}$	Contact thermal resistance	Case to heat sink, Thermal grease applied per 1 module, (Note4, 7)	-	15	-	K/kW

MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
M_t	Mounting torque	Main terminals M 6 screw	3.5	4.0	4.5	N·m
M_s	Mounting torque	Mounting to heat sink M 5 screw	2.5	3.0	3.5	N·m
d_s	Creepage distance	Terminal to terminal	17	-	-	mm
		Terminal to base plate	18.5	-	-	
d_a	Clearance	Terminal to terminal	10	-	-	mm
		Terminal to base plate	16.3	-	-	
e_c	Flatness of base plate	On the centerline X, Y (Note8)	±0	-	+100	μm
m	mass	-	-	350	-	g

*: This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU.

Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free-wheeling diode (FWD).

2. Junction temperature (T_{vj}) should not increase beyond T_{vjmax} rating.

3. Pulse width and repetition rate should be such that the device junction temperature (T_{vj}) dose not exceed T_{vjmax} rating.

4. Case temperature (T_C) and heat sink temperature (T_S) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.

5. Pulse width and repetition rate should be such as to cause negligible temperature rise. Refer to the figure of test circuit.

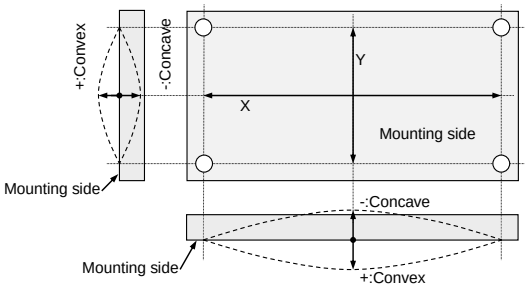
6. $B_{(25/50)} = \ln(\frac{R_{25}}{R_{50}}) / (\frac{1}{T_{25}} - \frac{1}{T_{50}})$

   R_{25}: resistance at absolute temperature T_{25} [K]; T_{25}=25 [°C]+273.15=298.15 [K]

   R_{50}: resistance at absolute temperature T_{50} [K]; T_{50}=50 [°C]+273.15=323.15 [K]

7. Typical value is measured by using thermally conductive grease of λ=0.9 W/(m·K)/$D_{(C-S)}$=50 μm.

8. The base plate (mounting side) flatness measurement points (X, Y) are shown in the following figure.



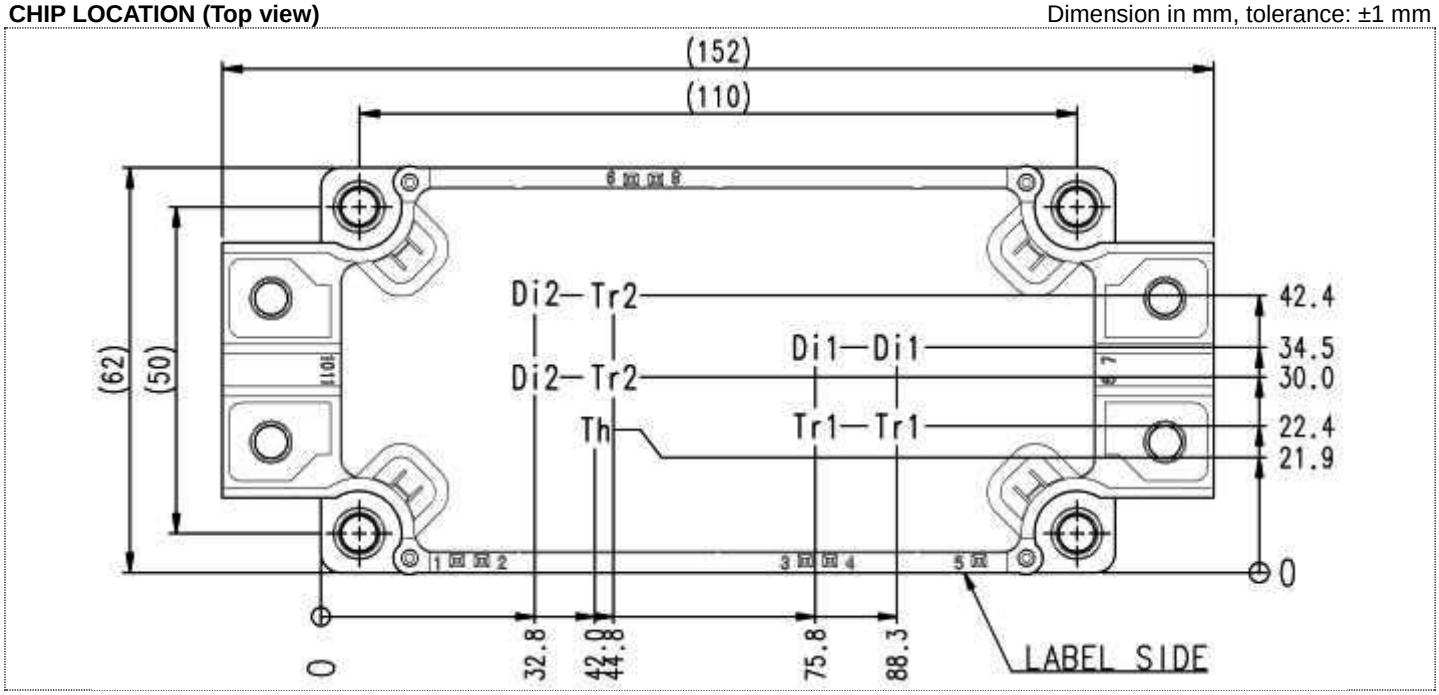
Note10. Use the following screws when mounting the printed circuit board (PCB) on the standoffs.
PCB thickness : t1.0~t1.6

Type	Manufacturer	Size	Tightening torque (N・m)	Recommended tightening method
(1) PT®	EJOT	K25×8	0.55 ± 0.055	by handwork (equivalent to 30 r/min by mechanical screw driver) ~ 600 r/min (by mechanical screw driver)
(2) PT®		K25×10	0.75 ± 0.075 N・m	
(3) DELTA PT®		25×8	0.55 ± 0.055 N・m	
(4) DELTA PT®		25×10	0.75 ± 0.075 N・m	
(5) B1 tapping screw	-	φ2.6×10	0.75 ± 0.075 N・m	
		φ2.6×12		

RECOMMENDED OPERATING CONDITIONS

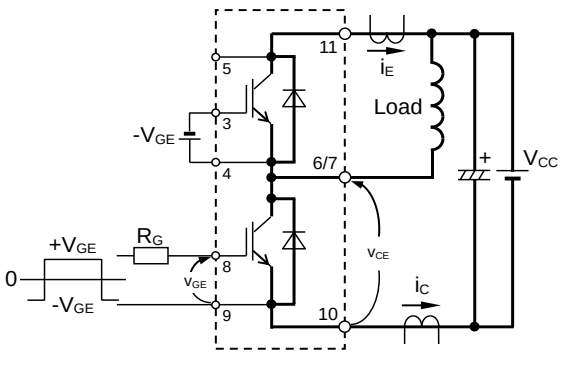
Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
V_{CC}	(DC) Supply voltage	Applied across C1-E2 terminals	-	1000	1200	V
V_{GEon}	Gate (-emitter drive) voltage	Applied across G1-E1s/G2-E2s terminals	13.5	15.0	16.5	V
R_G	External gate resistance	Per switch	0	-	38	Ω

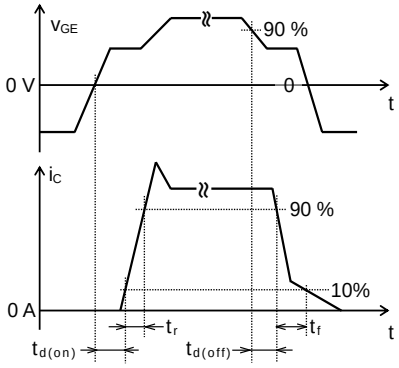
CHIP LOCATION (Top view) Dimension in mm, tolerance: ±1 mm



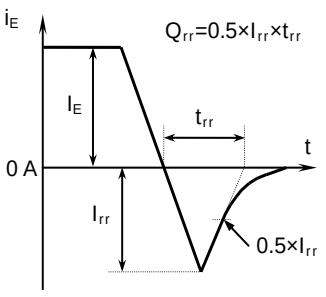
Tr1/Tr2: IGBT, Di1/Di2: FWD, Th: NTC thermistor

TEST CIRCUIT AND WAVEFORMS

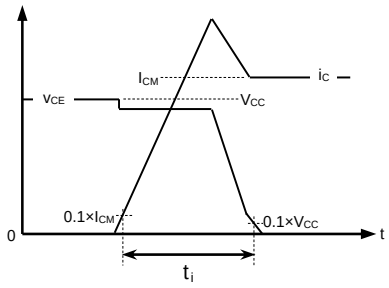




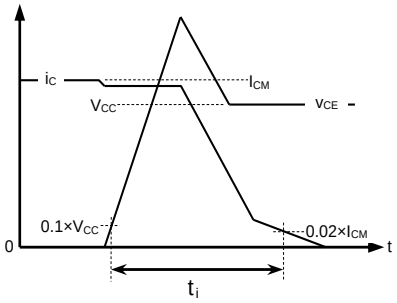
Switching characteristics test circuit and waveforms



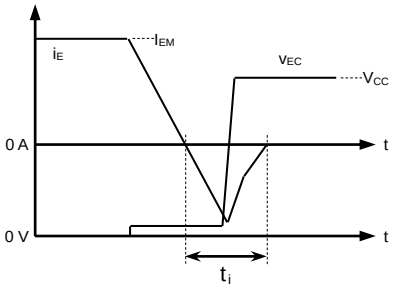
t_{rr}, Q_{rr} characteristics test waveform



IGBT Turn-on switching energy



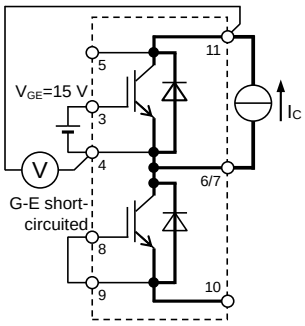
IGBT Turn-off switching energy



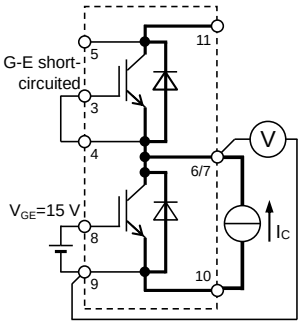
FWD Reverse recovery energy

Switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

TEST CIRCUIT

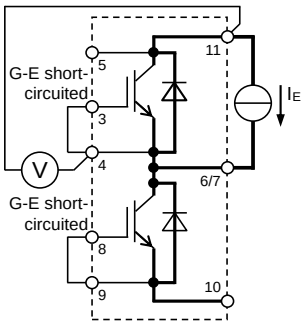


Tr1

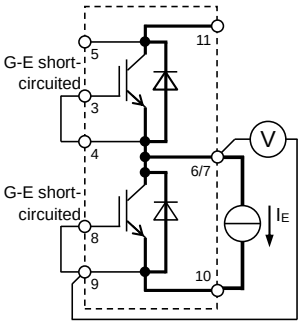


Tr2

V_{CEsat} characteristics test circuit



Di1



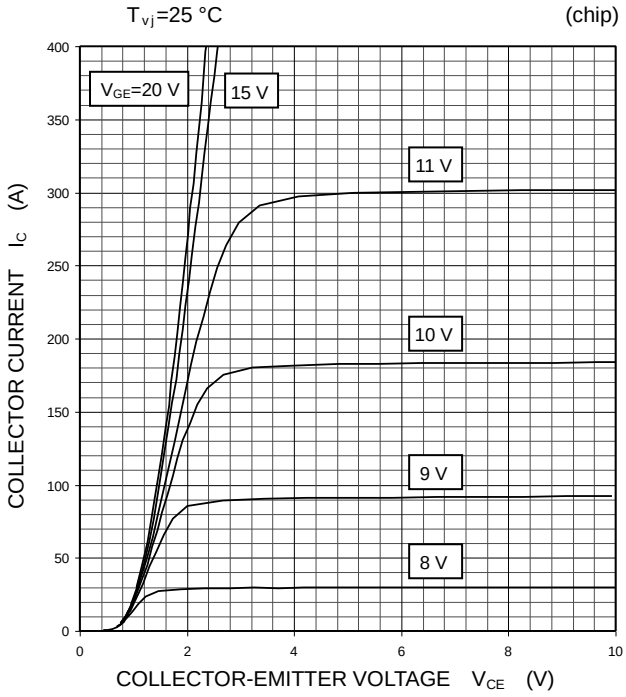
Di2

V_{EC} characteristics test circuit

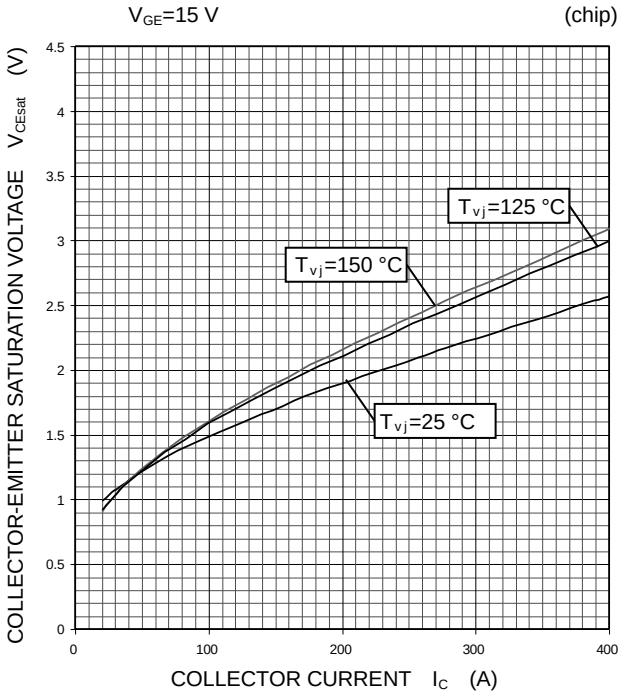
PERFORMANCE CURVES

INVERTER PART

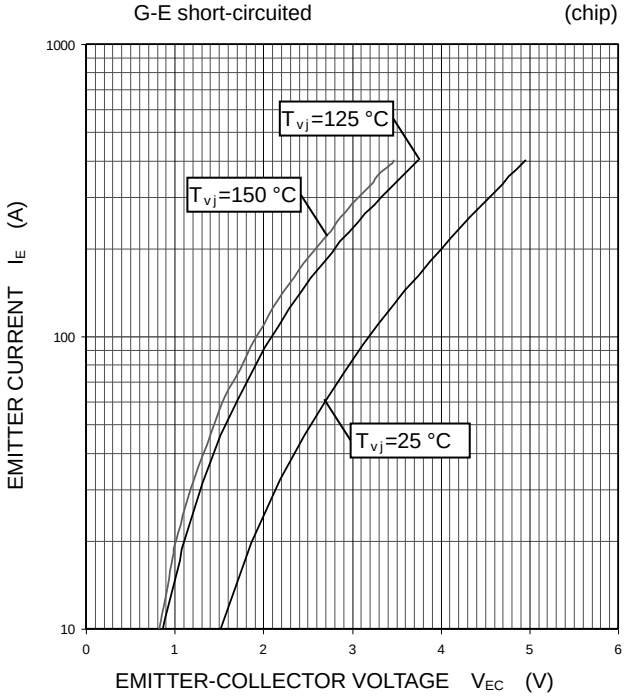
OUTPUT CHARACTERISTICS (TYPICAL)



COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)

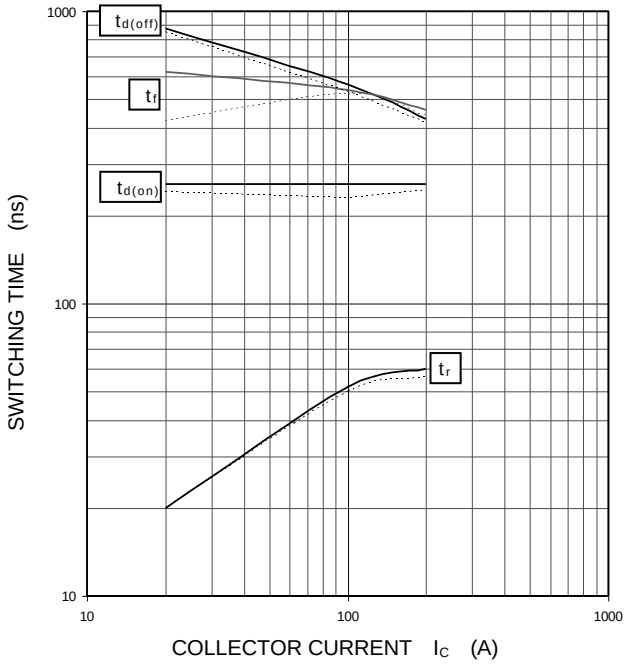


PERFORMANCE CURVES

INVERTER PART

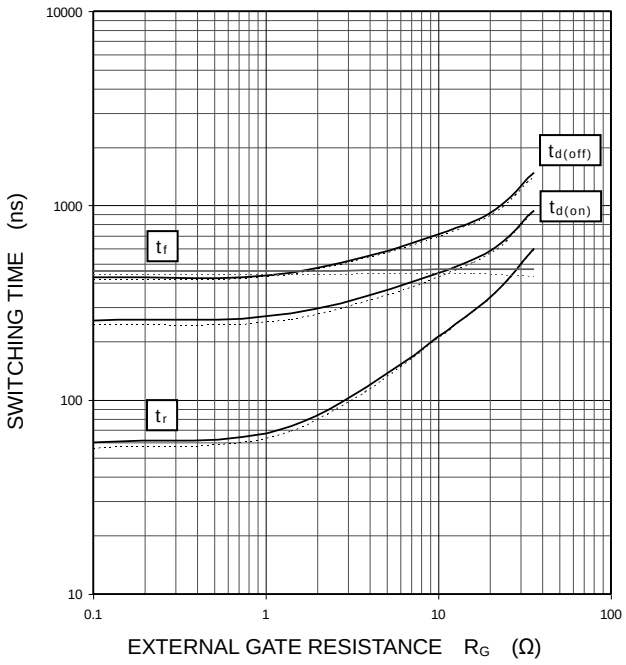
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

V_{CC}=1000 V, R_G=0 Ω, V_{GE}=±15 V, INDUCTIVE LOAD
————: T_{vj}=150 °C, - - - - -: T_{vj}=125 °C



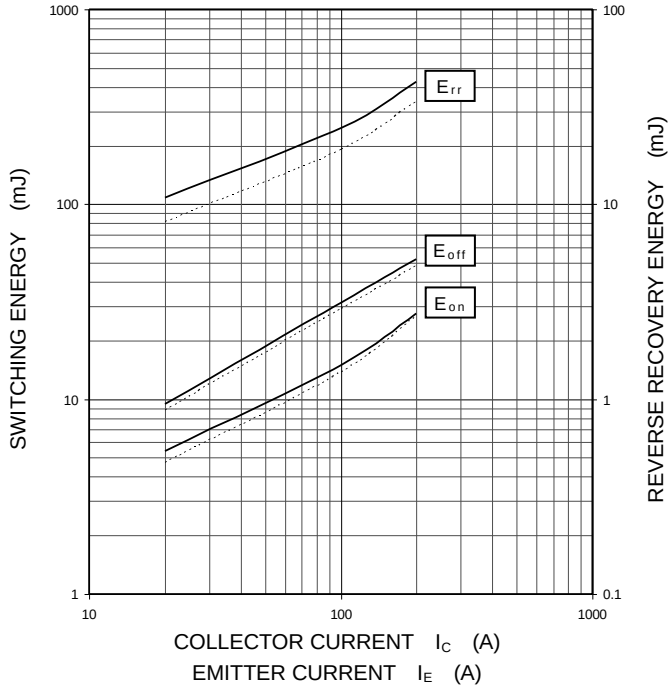
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

V_{CC}=1000 V, I_C=200 A, V_{GE}=±15 V, INDUCTIVE LOAD
————: T_{vj}=150 °C, - - - - -: T_{vj}=125 °C



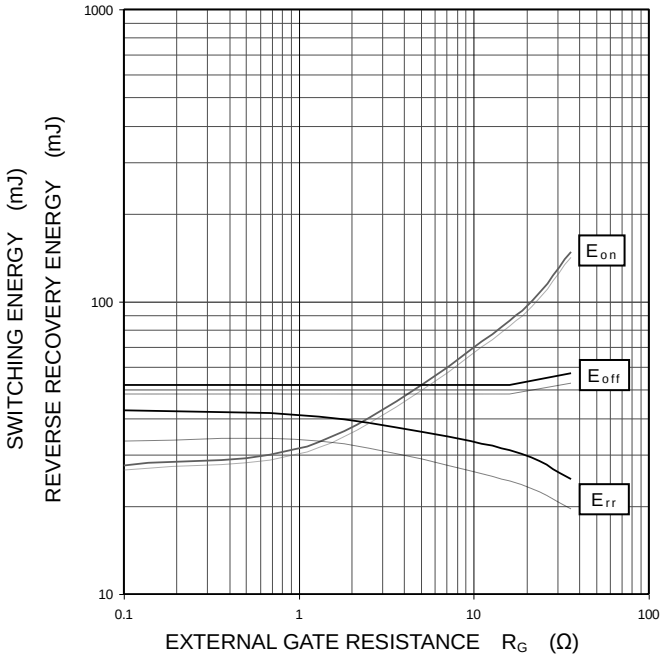
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

V_{CC}=1000 V, R_G=0 Ω, V_{GE}=±15 V, INDUCTIVE LOAD,
————: T_{vj}=150 °C, - - - - -: T_{vj}=125 °C, PER PULSE



HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

V_{CC}=1000 V, I_C/I_E=200 A, V_{GE}=±15 V, INDUCTIVE LOAD,
————: T_{vj}=150 °C, - - - - -: T_{vj}=125 °C, PER PULSE

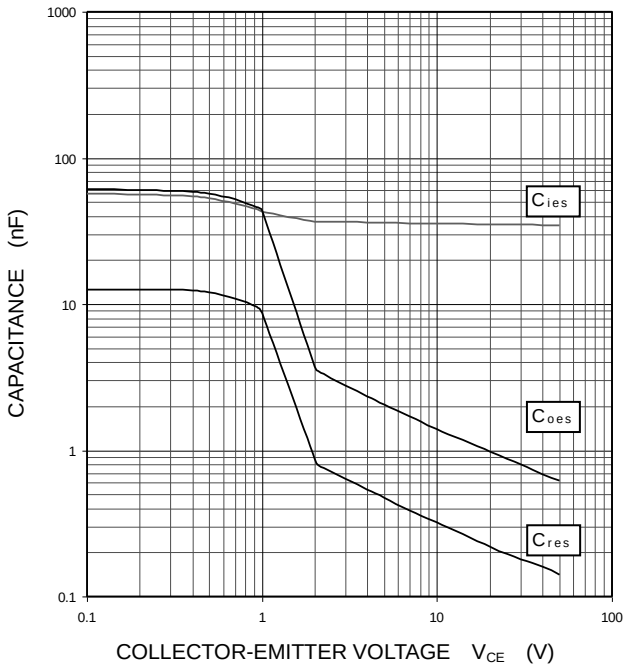


PERFORMANCE CURVES

INVERTER PART

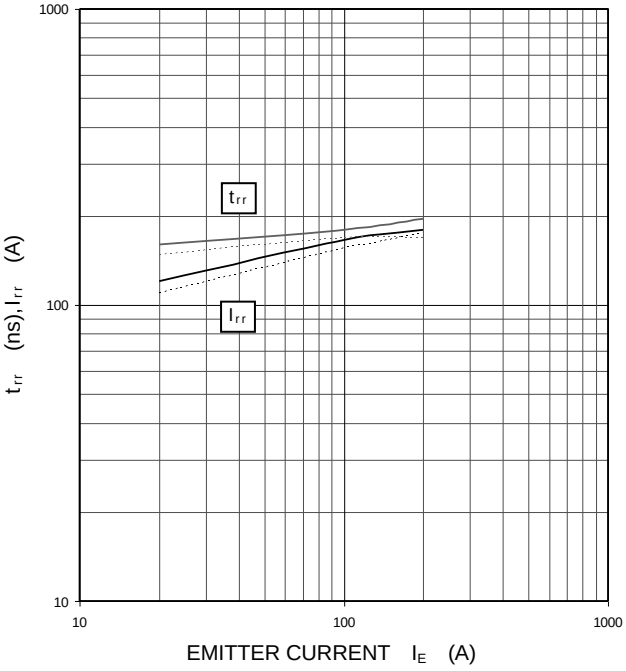
CAPACITANCE CHARACTERISTICS (TYPICAL)

G-E short-circuited, T_{vj}=25 °C



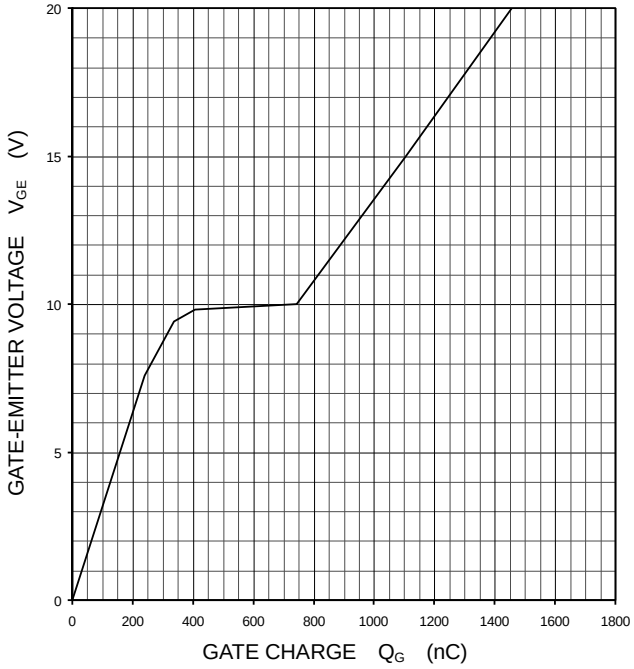
FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)

V_{CC}=1000 V, R_G=0 Ω, V_{GE}=±15 V, INDUCTIVE LOAD
———: T_j=150 °C, - - - - -: T_j=125 °C



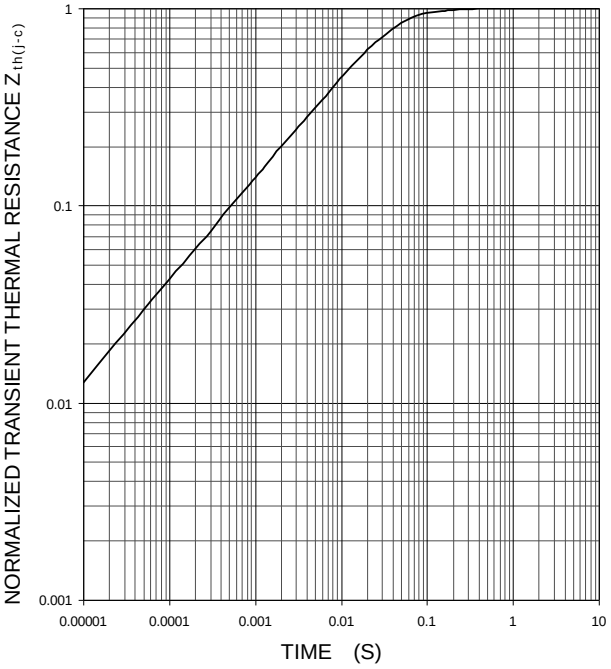
GATE CHARGE CHARACTERISTICS (TYPICAL)

V_{CC}=1000 V, I_C=200 A, T_{vj}=25 °C



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)

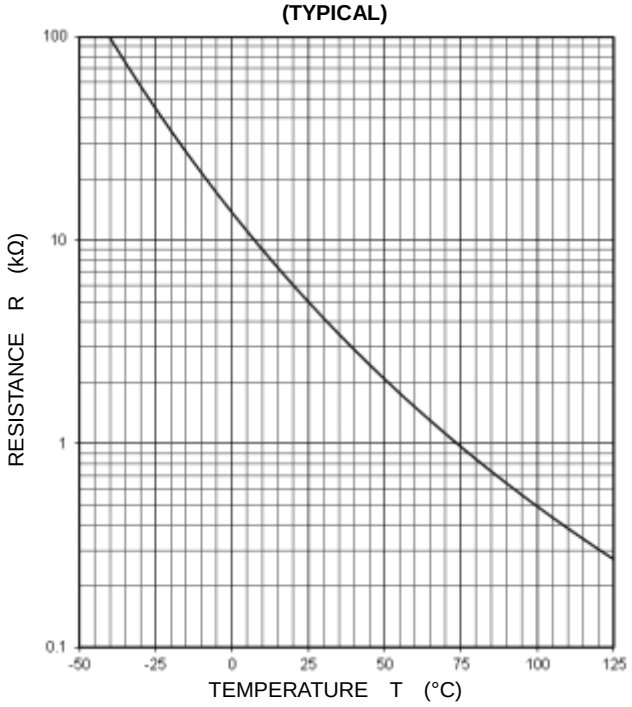
Single pulse, T_C=25 °C
$R_{th(j-c)Q}$=75 K/kW, $R_{th(j-c)D}$=120 K/kW



PERFORMANCE CURVES

NTC thermistor part

TEMPERATURE CHARACTERISTICS (TYPICAL)



Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

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